

Effects of CeO₂ on the Si Precipitation Mechanism of SiCp/Al-Si Composite Prepared by Powder Metallurgy

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Abstract: SiCp/Al-Si composites with di erent CeO₂ contents were prepared by a powder metallurgy method. The e ect of CeO₂ content on the microstructure of the composites was studied. The mechanism of CeO₂ on the precipitation of Si during sintering was analyzed by theoretical calculations. The results show that the appropriate amount of CeO₂ can significantly refine the size of precipitated Si particles in the composite and increase the number of Si particles. With the increase of CeO₂ content from 0 to 0.6 wt%, the number of Si particles precipitated in the composites increases gradually, and the average particle size of Si particles decreases gradually. When the CeO₂ content is 0.6 wt%, the number of Si particles precipitated in the composites reaches the maximum, and the average particle size reaches the minimum. However, with the increase of CeO₂ content from 0.6 wt% to 1.8 wt%, the number of Si particles precipitated in the composites began to decrease, and the average size of Si particles gradually increased. CeO₂ can be used as heterogeneous nucleation substrate of precipitated Si, and the nucleation rate of precipitated Si on a CeO₂ substrate is higher than that on an aluminum substrate. The proper addition of CeO₂ can improve the nucleation e ciency of precipitated Si, thus increasing the amount and refining the size of precipitated Si.

Keywords: powder metallurgy; rare earth element; precipitated Si; microstructure refinement

1. Introduction

With the development of the modern manufacturing industry, research and development of high-performance materials has become one of the important topics in the development of the aerospace industry [1–3]. In spacecraft design, due to the particularities of the space flight environment, the materials used for the vessel and its auxiliary equipment are usually required to have ultra-high specific strength and toughness, good high-temperature performance and thermal stability, as well as remarkable fatigue resistance, vibration resistance, corrosion resistance, etc. [4–7].

Due to the advantages of low density, high specific strength, low thermal expansion coe cient, good thermal conductivity and high wear resistance, SiC particle reinforced Al-Si matrix composite (SiCp/Al-Si composite) has been widely used in aerospace applications, electronic instruments, military equipment, wear-resistant materials and many other fields [8–12]. SiCp/Al-Si composites prepared by powder metallurgy usually have the following advantages: the distribution of the reinforcement phase is uniform, the content is easy to adjust, the proportion of each component is accurate and there is no obvious agglomeration [13,14]. In addition, due to the low temperature used in the preparation

process, the composites are generally in solid or partial melting state, so the interfacial reaction between matrix and reinforcement is very weak, which reduces the formation of interface impurities and brittle phases [15]. However, for the SiCp/Al-Si composites with high Si content in the matrix, multi-scale precipitation of Si phase will occur during the preparation process, and coarse and irregular Si particles will be precipitated in the matrix [16–18]. These particles can easily split the matrix, reduce the mechanical properties of the materials and restrict the improvement of its physical and mechanical properties. Therefore, it is of great significance to improve the physical and mechanical properties of SiCp/Al-Si composites by reducing or preventing the multi-scale precipitation of a Si phase during the preparation process.

At present, many scholars have studied the application of rare earths as grain refiner in casting Al-Si alloys [19–22]. Compared with other rare earth elements, Ce has been the most investigated due to its relatively low cost and good compatibility with the aluminum matrix. Li et al. [23] found that the addition of 1.0 wt% Ce significantly refined the primary Si and transferred the morphology from coarse irregular to fine blocky. Xue et al. [24] reported that CeO₂ additive could significantly improve the dispersion of in-situ formed TiB₂ in an Al matrix while refining -Al grains. Wu et al. [25] fabricated Ti/Al₂O₃ composites with di erent volume content of CeO₂ via vacuum hot-pressing sintering and found that the addition of CeO₂ could significantly improve the microhardness, flexural strength and fracture toughness. However, there are few reports on the application of CeO₂ in Al-Si alloy and Al-Si alloy matrix composites prepared by powder metallurgy and little attention has been paid to the e ects of CeO₂ on the microstructure of SiCp/Al-Si composites. In this paper, SiCp/Al-Si composites with di erent CeO₂ contents were prepared by a powder metallurgy method, the influence of CeO₂ content on the microstructure of the composites were studied and the mechanism of the influence of CeO₂ on the precipitation of Si phase in the composites was discussed.

2. Experimental Process

The SiCp/Al-Si composites with di erent CeO₂ contents were prepared by a powder metallurgy method. Al-19Si-1.5Cu-0.6Mg alloy powder prepared by the gas-atomization method was used as matrix, SiCp with average particle size of 10 m was selected as reinforcement material and its mass fraction was 20 wt%, The additive used in the experiments was high purity CeO₂ powder, which mass fraction was respectively 0, 0.15 wt%, 0.3 wt%, 0.6 wt%, 1.2 wt%, 1.8 wt%. First, the above powders were mixed by a ball mill (the ratio of balls to powder was 2:1) for 4 h and then dried. Next the mixed powders were cold-rolled to a diameter of 78 mm, length 48 mm billet with 500 MPa pressure in a hydraulic machine; then the billets were heated in a tube furnace, the sintering temperature was 550 °C, sintering time was 3 h (the protective gas was N₂).

The X-ray di raction (XRD) patterns of composites with di erent CeO₂ contents were determined using an X-pertpro X-ray di ractometer (PANalytical, Eindhoven, The Netherlands) with Cu K radiation (k = 0.15406 nm) operated at 40 kV and 100 mA. The microstructure of the samples were observed using scanning electron microscopey (SEM, JSM-5600LV, JEOL, Tokyo, Japan) with energy dispersive spectroscopy (EDS, Kevex, Texas, TX, USA) and transmission electron microscopy (TEM, JEOL JEM-2100). Samples for SEM analysis were prepared via grinding with SiC abrasive papers and polishing with an Al₂O₃ suspension solution and diamond solutions of di erent abrasive sizes (6, 3, 1 and 0.3 m). After metallographic polishing, the samples were corroded by Keller reagent for 30 s. The TEM foil was mechanically polished to about 20 m and further thinned via ion milling with a precision ion polishing system (PIPS, Model 691, Gatan, Pleasanton, CA, USA). The average grain size of Si particles precipitated from the composites with di erent CeO₂ content was measured by Image Pro Plus software v6.0. This software generates histograms of precipitated Si particles from the SEM image and quantifies the diameter of precipitated Si through line profile analysis which provides the average grain size of all precipitated Si particles.

3. Results and Discussion

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3.1. The XRD Analysis of SiCp/Al-Si Composites with Different CeO₂ Contents

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be seen that all the samples contain the di raction peaks of Al matrix (JCPDS card No.04–0787), SiC particles (JCPDS card No. 29–1131) and precipitated Si (JCPDS card No. 27–1402). However, due to the relatively low amount of addition and the fact the diffraction peaks of CeO₂ overlap with those the relatively low amount of addition and the fact the di raction peaks of CeO₂ (JCPDS card No. 34–0394)z is only found in the precipitated Si, the diffraction peak of CeO₂ (JCPDS card No. 34–0394)z is only found in the precipitated Si, the di raction peak of CeO (JCPDS card No. 34–0394) is only found in the composites composites with 1.8 wt% CeO₂ content, and 2 the diffraction peak intensity is weak. This shows that with 1.8 wt% CeO₂ content, and 2 the with 1.8 wt% CeO content, and the di raction peak intensity is weak. This shows that CeO₂ does not react during the preparation2 the composite relatively stable, and the CeO₂ does not react during the preparation2

process.

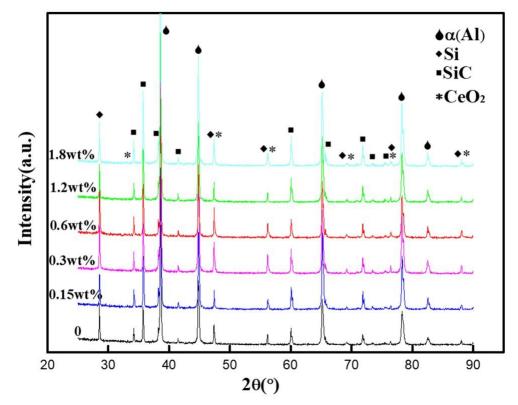


Figure 1. XRD pattern of SiCpSiCp/AI/-Si Composites with didifferentCeO Contents.Figure1.XRDpatternof-SiCompositeswithCeO22 Contents.

3.2. E ect of CeO₂ Additions on the Microstructure of SiCp/Al-Si Composites
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Figure 2 shows the SEM and EDS images of SiCp/Al-Si Composites with di erent CeO₂ contents.
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It can be seen that the microstructure of the composites mainly consists of three phases: a dark gray particle phase (as shown in region A in Figure 2f), a light gray particle phase (as shown in region B in particle phase (as shown in region A in Figure 2f), a light gray particle phase (as shown in region B rigure 2f) and a white particle phase (as shown in region C in Figure 2f). Combining the XRD analysis in Figure 2f) and a white particle phase (as shown in region C in Figure 2f). Combining the XRD analysis in Figure 2f) and the EDS results in Figure 2f-i, it can be concluded that the dark gray particle phase in analysis in Figure 1 and the EDS results in Figure 2f-i, it can be concluded that the dark gray particle phase in analysis in Figure 1 and the EDS results in Figure 2f-i, it can be concluded that the dark gray particle phase in analysis in Figure 1 and the EDS results in Figure 2f-i, it can be concluded that the dark gray particle phase in analysis in Figure 1 and the EDS results in Figure 2f-i, it can be concluded that the dark gray particle phase in analysis in Figure 1 and the EDS results in Figure 2f-i, it can be concluded that the dark gray particle phase in analysis in Figure 1 and the EDS results in Figure 2f-i, it can be concluded that the dark gray particle phase in analysis in Figure 1 and the EDS results in Figure 2f-i, it can be concluded that the dark gray particle phase in analysis in Figure 1 and the EDS results in Figure 2f-i, it can be concluded that the dark gray particle phase in analysis in Figure 1 and the EDS results in Figure 2f-i, it can be concluded that the dark gray particle phase in analysis in Figure 2f-i.

the composites is SiCp, the light gray particle phase is precipitated Si and the white particle phase is phase in the composites is SiCp, the light gray particle phase is precipitated Si and the white particle CeO2. phase is CeO₂.

The average diameter of Si particles precipitated in the composites with different CeO₂ contents is shown in Figure 3. It can be seen that when the content of CeO2 is between 0 and 0.6 wt%, the average size of precipitated Si particles gradually decreases with the increase of CeO2 content, and the number of precipitated Si particles gradually increases; when the content of CeO2 is between 0.6 wt% and 1.8 wt%, the change trend of average size and number of precipitated Si particles is opposite to the above, the main reason for this phenomenon may be that the agglomeration of CeO2 increases with the increase of CeO₂ content. When the content of CeO₂ is less than 0.6 wt%, CeO₂ mainly exists in the form of particles, and when the content of CeO2 is more than 0.6 wt%, the agglomeration of

 CeO_2 in the composite increases. Obviously, an appropriate amount of CeO_2 can refine the precipitated Si, When the CeO_2 content is 0.6 wt%, the number of Si particles precipitated in the composites reaches the maximum and the average particle size reaches the minimum.

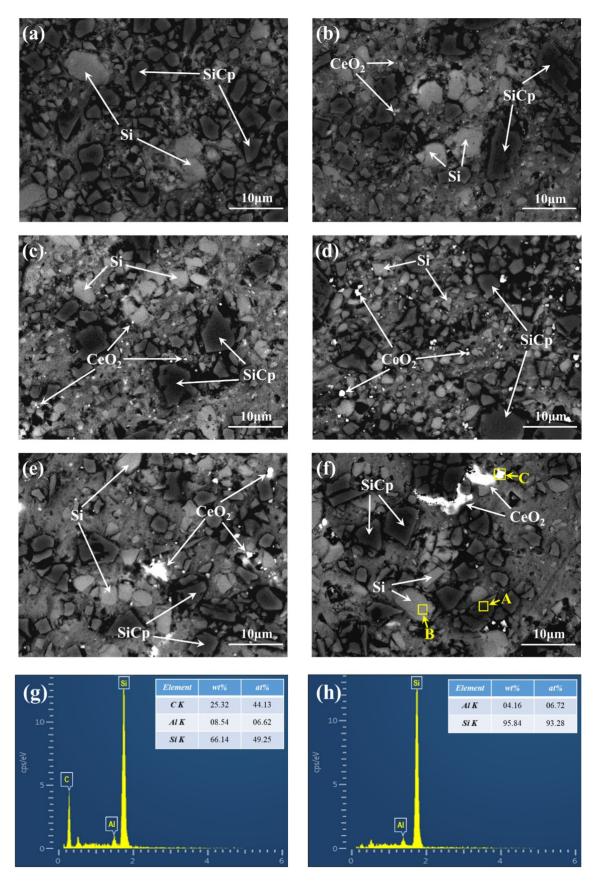


Figure 2. Cont.

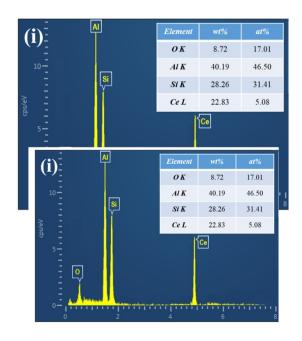


Figure 2. The SEM and EDS pictures of SiCp/Al-Si Composites with di erent CeO₂ Contents: (a) 0; (b)

Figure 2. The SEM and EDS pictures of SiCp/Al-Si Composites with different CeO₂ Contents: (a) 0; 0.15 wt%; (c) 0.30 wt%; (d) 0.60 wt%; (e) 1.20 wt%; (f) 1.80 wt%; (g) the energy spectrum diagram of (b) 0.15 wt%; (c) 0.30 wt%; (d) 0.60 wt%; (e) 1.20 wt%; (f) 1.80 wt%; (g) the energy spectrum diagram region A in Figure 2f; (h) the energy spectrum diagram of region B in Figure 2f; (i) the energy spectrum of region A in Figure 2f; (h) the energy spectrum diagram of region B in Figure 2f; (i) the energy diagram of region C in Figure 2f. spectrum diagram of region C in Figure 2f.

ricles, and when the content of CeO is more than 0.6 wt%, the agglomeration of CeO Track the particles. The calculated results about 2 in the the composite averaged iameter increases of SiObviously, precipitated an in appropriatecompositesareamountconsistentof CeOwith2thecanmicrostructurerefinetheprecipitatedanalysis. Si.

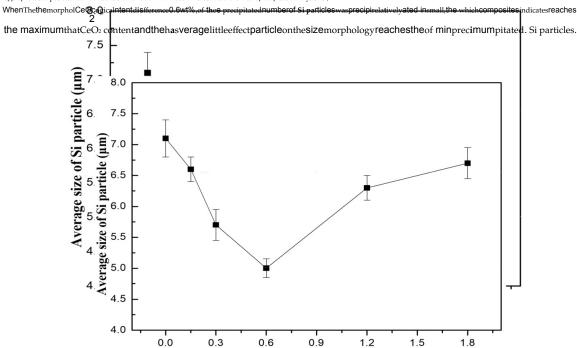


Figure 3. Average size of Si particles precipitated from SiCp/Al-Si composites with different

contents of CeO₂.

Figure 3. Average size of Si particles precipitated from SiCp/Al-Si composites with di erent contents of Figure 3. Average size of Si

Content of CeO, (wt%)

3.3. Influence Mechanism of CeO₂ on the Microstructure of -Si Composites with different contents of CeO $_2$ on the Microstructure of -Si Composites $_2$ CeO $_3$.

In order to study the influence mechanism of CeO2 on the size and quantity of precipitated Si in 3.3. Influence Mechanism of CeO2 on the Microstructure of SiCp/Al-Si Composites

the composites, the composite without CeO₂ and the composite with 0.6 wt% CeO₂ In order to study the influence mechanism of CeO₂ on the size and quantity of precipitated Si in the composites, the composite without CeO₂ and the composite with 0.6 wt% CeO₂ content were

The existence of CeO₂ can slow down the di usion of precipitated Si atoms in Al matrix, thus reducing the growth rate of precipitated Si and refining the particles. The calculated results about the average diameter of Si precipitated in composites are consistent with the microstructure analysis. The morphological di erence of the precipitated Si particles was relatively small, which indicates that

CeO₂ content has little e ect on the morphology of precipitated Si particles.

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3.3. Influence Mechanism of CeO₂ Materials 2020, 13, x FOR PEER REVIEW

on the Microstructure of SiCp/Al-Si Composites

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analyzed by TEM. Figure 4 shows the TEM microstructure and corresponding electron diffraction in the composite, the composite without CeO and the composite with 0.6 wt% CeO content were patterns of the SiCp/Al-Si composite without CeO22. After calibration by the software 2MDI jade 5.0, analyzed by TEM. Figure 4 shows the TEM microstructure and corresponding electron diffraction analyzed by TEM. Figure 4 shows the TEM microstructure and corresponding electron diffraction analyzed by TEM. Figure 4 shows the TEM microstructure and corresponding electron diffraction analyzed by TEM. Figure 4 shows the TEM microstructure and corresponding electron diffraction analyzed by TEM. Figure 4 shows the TEM microstructure and corresponding electron diffraction analyzed by TEM. Figure 4 shows the TEM microstructure and corresponding electron diffraction analyzed by TEM. Figure 4 shows the TEM microstructure and corresponding electron diffraction analyzed by TEM. Figure 4 shows the TEM microstructure and corresponding electron diffraction analyzed by TEM. Figure 4 shows the TEM microstructure and corresponding electron diffraction analyzed by TEM. Figure 4 shows the TEM microstructure and corresponding electron diffraction analyzed by TEM. Figure 4 shows the TEM microstructure and corresponding electron diffraction analyzed by TEM. Figure 4 shows the TEM microstructure and corresponding electron diffraction analyzed by TEM. Figure 4 shows the TEM microstructure and corresponding electron diffraction analyzed by TEM. Figure 4 shows the TEM microstructure and corresponding electron diffraction analyzed by TEM. Figure 4 shows the TEM microstructure and corresponding electron diffraction analyzed by TEM. Figure 4 shows the TEM microstructure and corresponding electron diffraction analyzed by TEM. Figure 4 shows the TEM microstructure and corresponding electron diffraction analyzed by TEM. Figure 4 shows the TEM microstructure and corresponding electron diffraction analyzed by TEM. Figure 4 shows the TEM microstructure and correspo

Calibration by the software MDI jade

Al matrix is the main nucleation substrate for the precipitated 2 Si in the composites without CeO2 the electron diffraction patterns should be Al and precipitated Si, respectively. This indicates that the 5.0, the electron diffraction patterns should be Al and precipitated Si, respectively. This indicates Figure 5 shows the TEM microstructure and corresponding electron diffraction patterns of the Al matrix is the main nucleation substrate for the precipitated Si in the composites without CeO2. that the Al matrix is the main nucleation substrate for the precipitated Si in the composites without SiCp/Al-Si composite 0.6 wt% CeO2 content, and diffraction patterns calibration indicated that they Figure 5 shows the TEM microstructure and corresponding electron diffraction patterns of shouldate De CeO2 and precipitated Si, respectively. It can be concluded that in addition to Al matrix as SiCp/Al-Si composite 0.6 wt% CeO2 content, and diffraction patterns calibration indicated that they the nucleation substrate for precipitated Si, respectively. It can be concluded that in addition to Al matrix as should be CeO2 and precipitated Si, respectively. It can be concluded that in addition to Al matrix as should be CeO3 and precipitated Si, respectively. It can be concluded that in addition to Al matrix as should be CeO3 and precipitated Si, respectively. It can be concluded that in addition to Al matrix as should be CeO3 and precipitated Si, respectively. It can be concluded that in addition to Al matrix as should be CeO3 and precipitated Si, respectively. It can be concluded that in addition to Al matrix as should be CeO3 and precipitated Si, respectively. It can be concluded that in addition to Al matrix as should be CeO3 and precipitated Si, respectively. It can be concluded that in addition to Al matrix as should be CeO3 and precipitated Si, respectively. It can be concluded that in addition to Al matrix as should be CeO3 and precipitated Si, respectively. It can be concluded that

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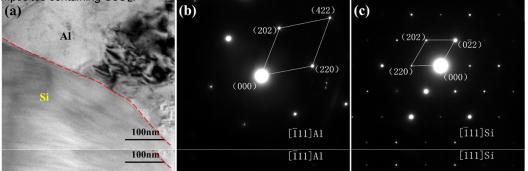


Figure 4. TEM observation of SiCp/Al-Si composites without CeO2: (a) Al-Si interface; (b) Diffraction Figure 4. TEM observation of SiCp/Al-Si composites without CeO2: (a) Al-Si interface; (b) Diffraction patterns of the Al matrix; (c) Diffraction patterns of the Precipitated Si.

patterns of the Al matrix; (c) Diffraction patterns of the precipitated Si.

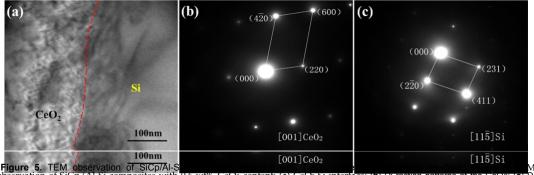


Figure 5. TEM observation of SiCp/Al-S observation of SiCp/Al-Si composites with 0.6 wt% CeO2 content: (a) CeO2-Si interface; (b) Di raction patterns of the precipitated Si. Figure 5. TEM observation of SiCp/Al-Si composites with 0.6 wt% CeO2 content: (a) CeO2-Si interface;

(Accordingb)Diffractiontopattertheanalysisofthe of CeOTEM2:(c) images Diffraction and patterns the corresponding of the precipitated electron Si. diraction patterns of According to the analysis of TEM images and the corresponding electron diffraction patterns of the the composites, it can be determined that CeO₂ could be used as the nucleation substrate of precipitated composites, it can be determined that CeO₂ could be used as the nucleation substrate of precipitated Si, so According to the analysis of TEM im^{and}ges and the corresponding electron diffraction patterns of the

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refine the size of precipitated Si particles. Table 1 shows the basic composites, it can be determined that CeO could be used as the nucleation substrate of precipitated Si, so the basic physical parameters of precipitated Si, CeO2 and Al. It can be seen that the precipitated Si, CeO2 and Al as to improve the nucleation rate and refine the size of precipitated Si, physical parameters of precipitated Si, CeO2 and Al. It can be seen that the corrected cubic crystal system. However, the difference of lattice co

constant values between precipitated Si and2 Al is larger than that of precipitated Si and matrix belong to the face-centered cubic crystal system. However, the difference of lattice constant values between precipitated Si and Al is larger than that of precipitated Si and CeO₂.

Table 1. Basic physical parameter of Si, CeO₂ and Al.

| Phase | Melting Point (K) | Crystal Structure | Lattice Constant (Å) |
|------------------|-------------------|-------------------|----------------------|
| Si | 1673 | FCC | 0.6636 |
| CeO ₂ | 2873 | FCC | 0.5411 |
| Al | 933 | FCC | 0.4050 |

Turnbull and Vonnegut first proposed that the heterogeneous nucleation e ciency of nucleation substrate depends on the lattice mismatch between the nucleation substrate and the nucleation phase [26]. The theory holds that the smaller the mismatch degree between nucleation substrate and nucleation phase is, the more lattice matching between nucleation substrate and nucleation phase is, and the energy caused by lattice mismatch between nucleation substrate and nucleation phase is smaller, too. That is, the smaller the interface energy between nucleation substrate and nucleation phase is, the higher nucleation rate of nucleation phase is. Because the precipitated Si,

CeO₂ and Al are face centered cubic structure, the mismatch degree of precipitated Si and two nucleation substrates can be expressed by one-dimensional mismatch degree:

$$= ja_S a_{n}j/a_{n}$$
 (1)

In Equation (1), a_S is the lattice constant of nucleation substrate, Å; and a_N is the lattice constant of nucleation phase, Å. Substituting the values in Table 1 into Equation (1), the calculation shows that the mismatch degree of precipitated Si and CeO_2 is 0.22, and that of precipitated Si and Al is 0.64. According to the lattice mismatch theory, it can be concluded that the nucleation rate of the precipitated Si with CeO_2 as the nucleation substrate is greater than that with Al as the nucleation substrate because the mismatch degree of the precipitated Si and CeO_2 is less than that of the precipitated Si and Al. In addition, according to the crystal growth theory of solid phase transformation [27], the growth mechanism of precipitated Si is mainly di usion-controlled growth. Although the content of CeO_2 in the composites is relatively low, the existence of CeO_2 can still slow down the di usion of precipitated Si atoms in Al matrix, thus reducing the growth rate of precipitated Si and refining the particles.

3.4. Calculation of Nucleation Rate of Precipitated Si in Composites

The Al-Si alloy powder used in this study is supersaturated solid solution prepared by rapid solidification method, the precipitation process of solid solution Si during sintering is a solid phase transformation process, and the nucleation process of precipitated Si in composite materials belongs to heterogeneous nucleation. Compared with homogeneous nucleation, heterogeneous nucleation requires less energy, the formula of free energy di erence in heterogeneous nucleation system is as follows:

$$DG_{i} = VDG_{V} + A_{i} + VDG_{Si} DG_{di}$$
 (2)

In Equation (2), DG_i is the system free energy, J; DG_V is the unit volume free energy of precipitated Si, J/cm^3 ; V is the volume of precipitated Si particles, cm^3 ; i is the unit area interface energy between the precipitated Si and the nucleation substrate, J/cm^2 ; A is the interface area, cm^2 ; DG_{Si} is the unit volume elastic strain energy, J/cm^3 ; and DG_{di} is the surface energy at defects, J.

It is generally believed that VDG_V is nucleation driving force, $A_i + VDG_{si}$ is resistance to nucleation, and DG_{di} is the surface energy at non-equilibrium defects, which contributes to nucleation work and promotes nucleation. For the convenience of calculation, it is assumed that the interface area between nucleation and nucleation substrate is equal to the surface area of nucleation, therefore, DG_{di} can be expressed as:

$$DG_{di} = A_i$$
 (3)

where is the unit area surface energy of di erent nucleation substrates, J/cm². Hence, Equation (2) can be rewritten as:

$$DG_{i} = VDG_{V} + A_{i} + VDG_{Si} A_{i}$$
(4)

Therefore, the critical nucleation size r_{ki} and the critical nucleation Energy DG_{ki} of precipitated Si could be identified as Equations (5) and (6):

$$r = \frac{1}{ki} 2(i i)/(DG_V DG_{Si})$$
 (5)

$$DG_{ki} = 16 \left(i \right)^{3} / 3 (DGV DG_{si})^{2}$$
(6)

The nucleation rate for heterogeneous nucleation could be identified as Equation (7):

$$N_{i} = N_{0} \exp \frac{DG_{ki}}{kT} \exp \frac{DG_{A}}{kT}$$
 (7)

In Equation (7), N_i is the nucleation rate of di erent nucleation substrates, $1/(s \text{ cm}^3)$; k is Boltzmann's constant, T is absolute temperature, K; DG_A is the di usion activation energy, J; and N_0 is the atomic number of precipitated Si per unit volume, $1/(s \text{ cm}^3)$. Substituting Equation (6) into Equation (7), then the Equation (8) can be rewritten as:

$$N_{i} = \frac{N_{0}kT}{h} \exp \frac{\frac{16 (i i)^{3}}{3(DGV DGsi)^{2}}}{kT} \exp \frac{DGA}{kT}$$
(8)

where h is Planck constant.

Table 2 shows the parameter values for the nucleation of precipitated Si. According to the data in Table 2, it can be calculated that N_{CeO2} = 4.66 10^{12} (s cm³) ¹, N_{AI} = 3.33 10^{12} (s cm³) ¹, N_{CeO2} > N_{AI} . Therefore, it can be concluded by calculation that the nucleation rate of precipitated Si on CeO₂ substrate is higher than that on Al substrate. However, it should be noted that the nucleation rate of precipitated Si on CeO₂ substrate is not much higher than that on Al substrate. Because of the value of areal surface energy i for Al matrix (1 10 4) is higher than that of CeO₂ (1 10 5), it can be concluded by Equation (5) that the critical radius of Si with CeO2 as nucleation substrate is smaller than that with Al matrix as nucleation substrate. The decrease of the critical nucleation radius of precipitated Si will lead to the decrease of critical nucleation energy and the increase of nucleation rate. This is consistent with our calculation. The addition of CeO2 can not only provide more nucleation substrates for precipitated Si to improve the nucleation rate, so as to refine the size and increase the number of precipitated Si particles. Combined with the previous analysis, it can be concluded that when the content of CeO2 is less than 0.6 wt%, the refining e ect is gradually enhanced with the increase of CeO2 content, which happens because there are more and more CeO₂ as the nucleation substrate of precipitated Si, and the existence of CeO₂ can slow down the di usion of precipitated Si atoms in Al matrix, thus reducing the growth rate of precipitated Si and refining the particles. However, When the content of CeO₂ is higher than 0.6 wt%, the refining e ect is gradually weakened, which is due to the relatively serious agglomeration phenomenon caused by excessive CeO2 content, weakens the ability of hindering the growth of precipitated Si, and reduces the refining e ect.

Table 2. The parameter value for the nucleation of precipitated Si on di erent nucleation substrates.

| Parameter Value | | Nucleation Substrates | |
|-----------------|----------------------|-----------------------|-----------------------|
| | | Al Matrix | CeO ₂ |
| DGv | (J/cm ³) | 10 ⁴ | 104 |
| DGA | (J) | 2.19 10 19 | 2.19 10 19 |
| DG_{Si} | (J/cm ³) | 0 | 15 |
| N ₀ | $((s cm^3)^{-1})$ | 3.94 10 ²¹ | 3.94 10 ²¹ |
| i | (J/cm ²) | 4 10 ⁶ | 6 10 ⁶ |
| i | (J/cm ²) | 1 10 ⁴ | 5 10 ⁵ |
| k | `(J/k) ´ | 23 | 23 |
| | | 1.38 10 | 1.38 10 |
| h | (J s) | 6.62 10 34 | 6.62 10 34 |
| T | (K) | 823 | 823 |

4. Conclusions

- (1) SiCp/Al-Si composites with di erent CeO₂ contents were successfully prepared by a powder metallurgy method. When the content of CeO₂ is less than 0.6 wt%, CeO₂ mainly exists in the form of discrete particles and when the content of CeO₂ is more than 0.6 wt%, the agglomeration of CeO₂ increases.
- (2) An appropriate amount of CeO₂ can obviously refine the size of precipitated Si particles and increase the amount of Si particles. With the increase of CeO₂ content from 0 to 1.8 wt%, the number of precipitated Si particles first increases and then decreases, and the average size of precipitated Si particles first increases and then decreases, too. When the CeO₂ content is 0.6 wt%, the number of Si particles precipitated in the composites is the largest and the average size is the smallest.
- (3) For the composite without CeO₂, the nucleation of precipitated Si is mainly based on Al matrix. The addition of CeO₂ can be used as the heterogeneous nucleation substrate for precipitated Si, which improves the nucleation rate of precipitated Si. Moreover, the nucleation rate of precipitated Si on CeO₂ substrate is higher than that on Al substrate, which further improves the nucleation rate of precipitated Si, thus increasing the number of precipitated Si particles and refining the size of precipitated Si particles.

Author Contributions: Methodology, software, investigation, and data curation, B.Y. and A.W.; supervision, J.X., and S.W.; formal analysis, K.L. and C.L.; validation and resources, B.Y. and G.W. All the authors discussed the data and wrote the manuscript. All authors have read and agreed to the published version of the manuscript.

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Conflicts of Interest: The authors declare no conflict of interest.

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